

#### 400V N-Channel MOSFET

#### **General Features**

- Proprietary New Planar Technology
- $R_{DS(ON),typ.}$ =0.24  $\Omega$ @ $V_{GS}$ =10V
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

## **Applications**

- Adaptor Charger
- SMPS Power Supply
- LCD Panel Power

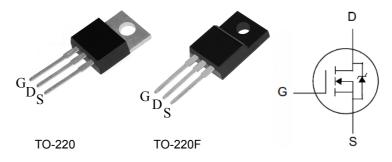
## **Ordering Information**

Part Number	Package	Brand
PTP20N40B	TO-220	Z
PTA20N40B	TO-220F	Z

**Absolute Maximum Ratings** 

### Lead Free Package and Finish

BV <sub>DSS</sub>	R <sub>DS(ON),typ.</sub>	I <sub>D</sub>
400V	0.24Ω	20A



Package No to Scale

#### $T_C$ =25 $^{\circ}$ C unless otherwise specified

Symbol	Parameter	PTP20N40B	PTA20N40B	Unit
V <sub>DSS</sub>	Drain-to-Source Voltage <sup>[1]</sup>	400		V
V <sub>GSS</sub>	Gate-to-Source Voltage	±	30	V
I <sub>D</sub>	Continuous Drain Current	2	0	
I <sub>D @ Tc =100</sub> ℃	Continuous Drain Current @ Tc=100℃	Figu	ire 3	Α
I <sub>DM</sub>	Pulsed Drain Current at V <sub>GS</sub> =10V <sup>[2]</sup>	Figure 6		
E <sub>AS</sub>	Single Pulse Avalanche Energy	1000		mJ
dv/dt	Peak Diode Recovery dv/dt[3]	5.0		V/ns
D	Power Dissipation	220	50	W
$P_D$	Derating Factor above 25℃	1.75	0.40	W/°C
T <sub>L</sub> T <sub>PAK</sub>	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260		${\mathbb C}$
T <sub>J</sub> & T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 150		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

#### **Thermal Characteristics**

Symbol	Parameter	PTP20N40B	PTA20N40B	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	0.57	2.5	20.11
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62	100	℃ <b>W</b>



### **Electrical Characteristics**

**OFF Characteristics** T<sub>J</sub> =25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
$BV_{DSS}$	Drain-to-Source Breakdown Voltage	400			V	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA
Durin to On one	Drain to Course Leglege Current			1	uA	V <sub>DS</sub> =400V, V <sub>GS</sub> =0V
I <sub>DSS</sub>	Drain-to-Source Leakage Current			100		$V_{DS}$ =320V, $V_{GS}$ =0V, $T_J$ =125°C
1	Cata to Source Leakage Current			+100	24	V <sub>GS</sub> =+30V, V <sub>DS</sub> =0V
I <sub>GSS</sub>	Gate-to-Source Leakage Current			-100	nA	V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V

**ON Characteristics** 

T<sub>J</sub> =25 ℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R <sub>DS(ON)</sub>	Static Drain-to-Source On-Resistance <sup>[4]</sup>		0.24	0.30	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =10A
V <sub>GS(TH)</sub>	Gate Threshold Voltage	2.0		4.0	٧	$V_{DS}$ = $V_{GS}$ , $I_D$ =250uA
gfs	Forward Transconductance <sup>[4]</sup>		18		S	VDS=15V,ID=10A

**Dynamic Characteristics** 

Essentially independent of operating temperature

Jilanii Gilaracterictice			oricially line	ating temperature		
Symbol	Parameter	Min.	Тур.	Max.	Unit	<b>Test Conditions</b>
C <sub>iss</sub>	Input Capacitance		2550			V -0V
C <sub>rss</sub>	Reverse Transfer Capacitance		33		pF	$V_{GS}$ =0V, $V_{DS}$ =25V, f=1.0MH <sub>Z</sub>
C <sub>oss</sub>	Output Capacitance		230			
$Q_g$	Total Gate Charge		35			
Q <sub>gs</sub>	Gate-to-Source Charge		12		nC	$V_{DD}$ =200V, $I_{D}$ =20A, $V_{GS}$ =0 to 10V
$Q_{gd}$	Gate-to-Drain (Miller) Charge		9.5			

**Resistive Switching Characteristics** 

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		25			
trise	Rise Time		50		20	$V_{DD}$ =200V, $I_{D}$ =20A,
td(OFF)	Turn-Off Delay Time		100		nS	$V_{GS}$ = 10V RG=25 $\Omega$
<b>t</b> fall	Fall Time		60			



## **Source-Drain Body Diode Characteristics**

 $T_J$ =25  $^{\circ}$ C unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I <sub>SD</sub>	Continuous Source Current <sup>[4]</sup>			20	۸	Integral PN-diode in
I <sub>SM</sub>	Pulsed Source Current <sup>[4]</sup>			80	Α	MOSFET
V <sub>SD</sub>	Diode Forward Voltage		-	1.5	V	I <sub>S</sub> =20A, V <sub>GS</sub> =0V
trr	Reverse recovery time		300		ns	$V_{GS}$ =0 $V$ , IF=20 $A$ ,
Qrr	Reverse recovery charge		1.0		uC	dir/dt=100A/μs

#### Note:

<sup>[1]</sup> T<sub>J</sub>=+25℃ to +150℃

<sup>[2]</sup> Repetitive rating; pulse width limited by maximum junction temperature. [3] ISD= 20A di/dt < 100 A/µs, VDD < BVDSS, TJ=+150 °C.

<sup>[4]</sup> Pulse width≤380µs; duty cycle≤2%.



## **Typical Characteristics**

Figure 1. Maximum Transient Thermal Impedance

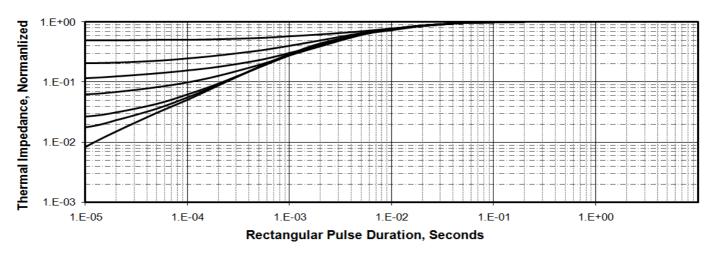


Figure 2. Max. Power Dissipation vs Case Temperature

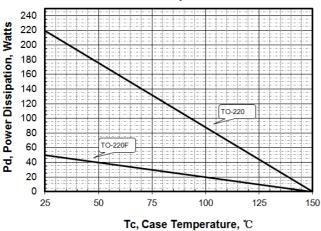


Figure 4. Output Characteristics

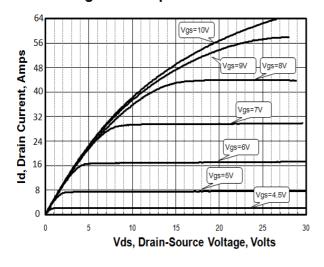


Figure 3 .Maximum Continuous Drain
Current vs Tc

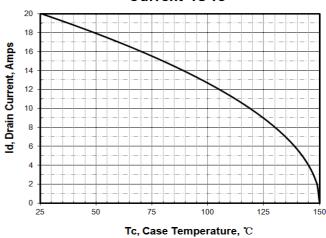
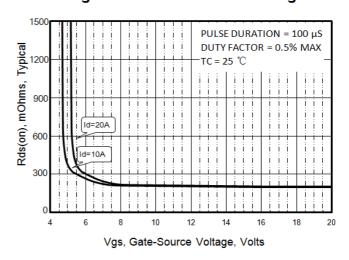


Figure 5. Rdson vs Gate Voltage





## **Typical Characteristics**(Cont.)

Figure 6. Peak Current Capability

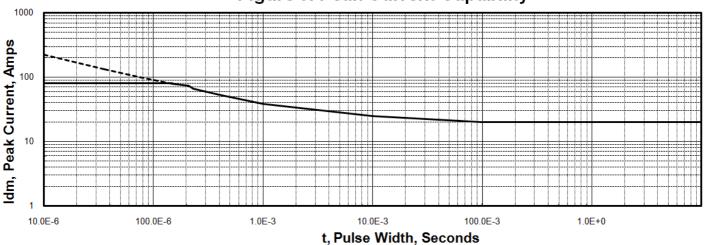


Figure 7. Transfer Characteristics

ld, Drain to Source Current, Amps 30 24 18 12 3.0 5.0 6.0 Vgs, Gate to Source Voltage, Volts

Figure 9. Drain to Source ON Resistance vs **Drain Current** 

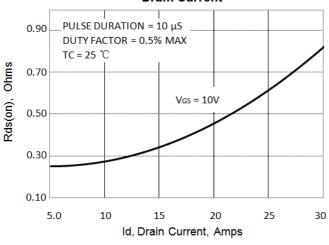


Figure 8. Unclamped Inductive Switching

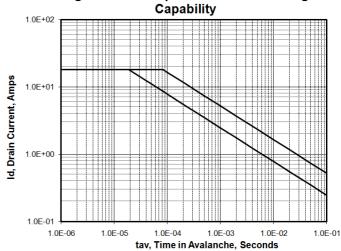
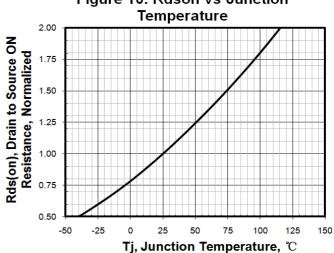


Figure 10. Rdson vs Junction





## **Typical Characteristics**(Cont.)

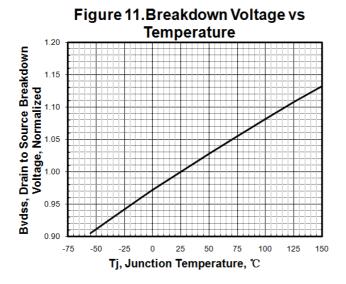


Figure 13. Maximum Safe Operating Area

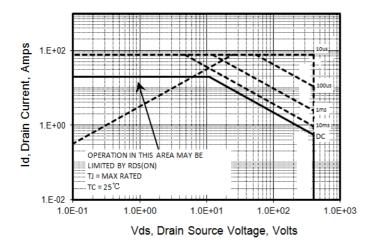


Figure 15 . Typical Gate Charge

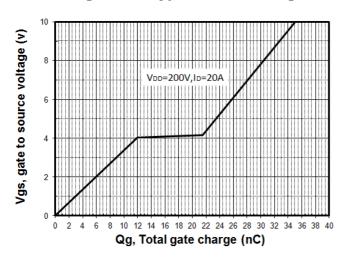


Figure 12. Threshold Voltage vs

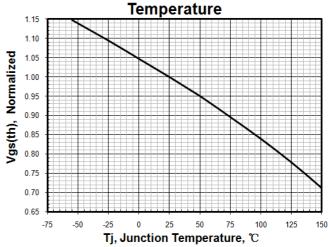


Figure 14. Capacitance vs Vds

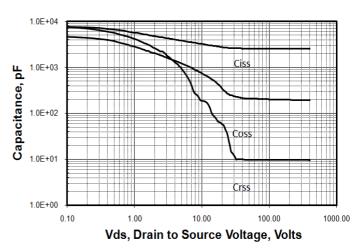
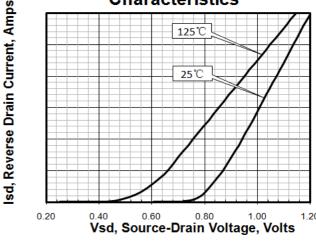


Figure 16.Body Diode Transfer Characteristics





## **Test Circuits and Waveforms**

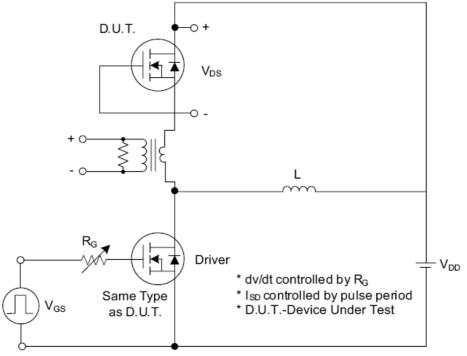


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

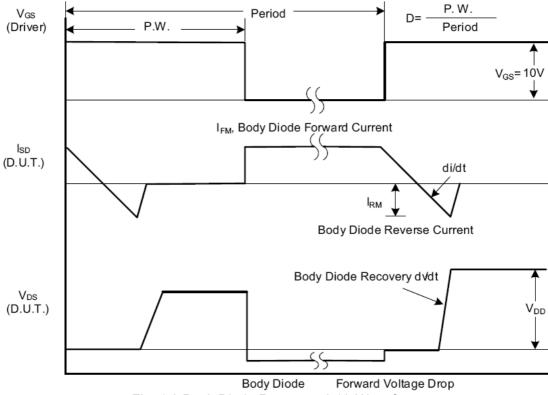


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms



# Test Circuits and Waveforms (Cont.)

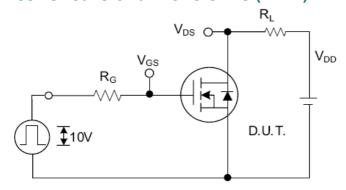


Fig. 2.1 Switching Test Circuit

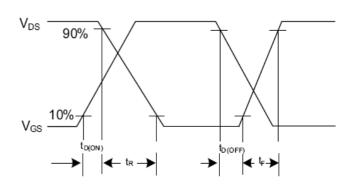


Fig. 2.2 Switching Waveforms

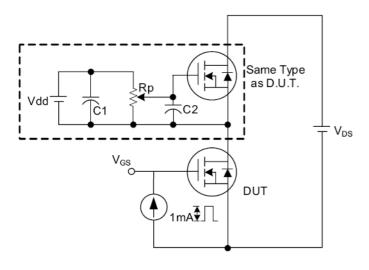


Fig. 3 . 1 Gate Charge Test Circuit

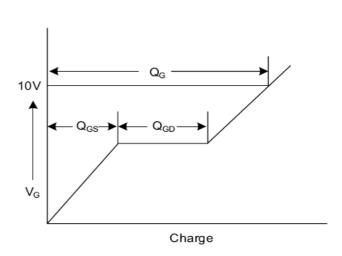


Fig. 3.2 Gate Charge Waveform

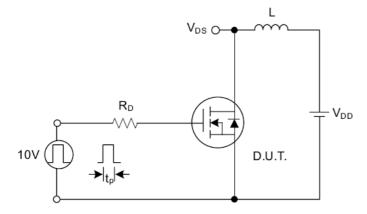


Fig. 4.1 Unclamped Inductive Switching Test Circuit

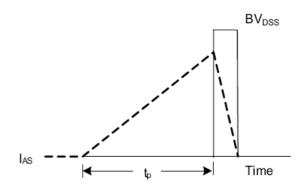


Fig. 4.2 Unclamped Inductive Switching Waveforms



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